

M5M5W816WG - 85HI

PRELIMINARY

Notice: This is not a final specification.  
Some parametric limits are subject to change

8388608-BIT (524288-WORD BY 16-BIT) CMOS STATIC RAM

Those are summarized in the part name table below.

DESCRIPTION

The M5M5W816 is a family of low voltage 8-Mbit static RAMs organized as 524288-words by 16-bit, fabricated by Mitsubishi's high-performance 0.18μm CMOS technology.

The M5M5W816 is suitable for memory applications where a simple interfacing, battery operating and battery backup are the important design objectives.

M5M5W816WG is packaged in a CSP (chip scale package), with the outline of 7.5mm x 8.5mm, ball matrix of 6 x 8 (48ball) and ball pitch of 0.75mm. It gives the best solution for a compaction of mounting area as well as flexibility of wiring pattern of printed circuit boards.

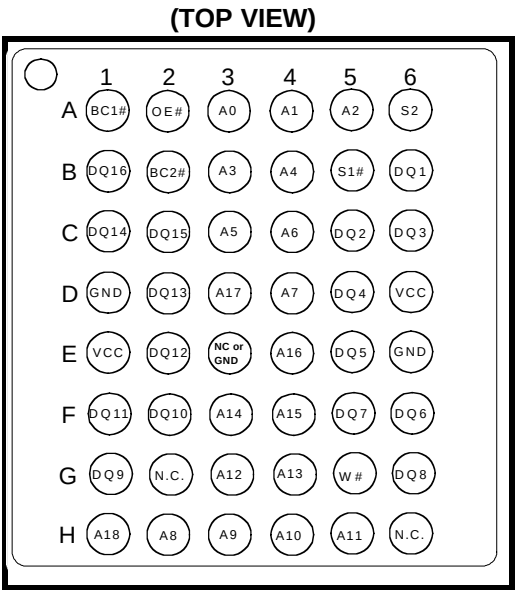
FEATURES

- Single 2.7~3.0V power supply
- Small stand-by current: 0.1μA (2V, typ.)
- No clocks, No refresh
- Data retention supply voltage =2.0V
- All inputs and outputs are TTL compatible.
- Easy memory expansion by S1#, S2, BC1# and BC2#
- Common Data I/O
- Three-state outputs: OR-tie capability
- OE prevents data contention in the I/O bus
- Process technology: 0.18μm CMOS
- Package: 48ball 7.5mm x 8.5mm CSP

| Version,<br>Operating<br>temperature | Part name            | Power<br>Supply | Access time<br>max. | Stand-by current |      |                |      |      |      | Active<br>current<br>Icc1<br>* ( typ.) |
|--------------------------------------|----------------------|-----------------|---------------------|------------------|------|----------------|------|------|------|----------------------------------------|
|                                      |                      |                 |                     | * Typical        |      | Ratings (max.) |      |      |      |                                        |
|                                      |                      |                 |                     | 25°C             | 40°C | 25°C           | 40°C | 70°C | 85°C |                                        |
| I-version<br>-40 ~ +85°C             | M5M5W816WG -<br>85HI | 2.7 ~ 3.0V      | 85ns                | 0.5              | 1.0  | 2              | 4    | 20   | 40   | 40mA<br>(10MHz)<br>10mA<br>(1MHz)      |

\* Typical parameter indicates the value for the center of distribution, and is not 100% tested.

PIN CONFIGURATION



| Pin        | Function              |
|------------|-----------------------|
| A0 ~ A18   | Address input         |
| DQ1 ~ DQ16 | Data input / output   |
| S1#        | Chip select input 1   |
| S2         | Chip select input 2   |
| W#         | Write control input   |
| OE#        | Output enable input   |
| BC1#       | Lower Byte (DQ1 ~ 8)  |
| BC2#       | Upper Byte (DQ9 ~ 16) |
| Vcc        | Power supply          |
| GND        | Ground supply         |

Outline : 48F7Q  
NC : No Connection  
\*Don't connect E3 ball to voltage level more than 0V

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FUNCTION

The M5M5W816WG is organized as 524288-words by 16-bit. These devices operate on a single +2.7~3.0V power supply, and are directly TTL compatible to both input and output. Its fully static circuit needs no clocks and no refresh, and makes it useful.

The operation mode are determined by a combination of the device control inputs BC1#, BC2#, S1#, S2, W# and OE#. Each mode is summarized in the function table.

A write operation is executed whenever the low level W# overlaps with the low level BC1# and/or BC2# and the low level S1# and the high level S2. The address(A0~A18) must be set up before the write cycle and must be stable during the entire cycle.

A read operation is executed by setting W# at a high level and OE# at a low level while BC1# and/or BC2# and S1# and S2 are in an active state(S1#=L,S2=H).

When setting BC1# at the high level and other pins are in an active stage, upper-byte are in a selectable mode in which both reading and writing are enabled, and lower-byte are in a non-selectable mode. And when setting BC2# at a high level and other pins are in an active stage, lower-byte are in a selectable mode and upper-byte are in a non-selectable mode.

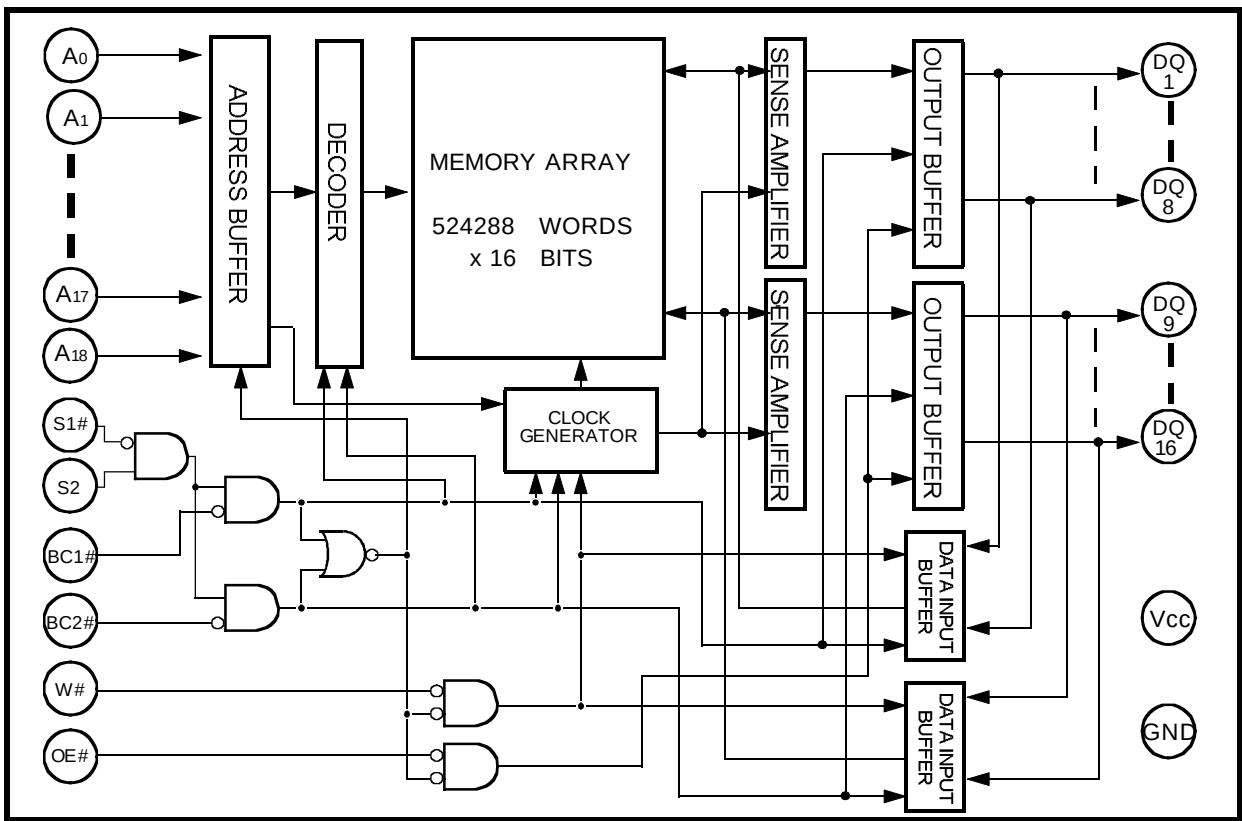
When setting BC1# and BC2# at a high level or S1# at a high level or S2 at a low level, the chips are in a non-selectable mode in which both reading and writing are disabled. In this mode, the output stage is in a high-impedance state, allowing OR-tie with other chips and memory expansion by BC1#, BC2# and S1#, S2.

The power supply current is reduced as low as 0.1μA(25°C, typical), and the memory data can be held at +2.0V power supply, enabling battery back-up operation during power failure or power-down operation in the non-selected mode.

FUNCTION TABLE

| S1# | S2 | BC1# | BC2# | W# | OE# | Mode          | DQ1~8  | DQ9~16 | Icc     |
|-----|----|------|------|----|-----|---------------|--------|--------|---------|
| H   | L  | X    | X    | X  | X   | Non selection | High-Z | High-Z | Standby |
| L   | L  | X    | X    | X  | X   | Non selection | High-Z | High-Z | Standby |
| H   | H  | X    | X    | X  | X   | Non selection | High-Z | High-Z | Standby |
| X   | X  | H    | H    | X  | X   | Non selection | High-Z | High-Z | Standby |
| L   | H  | L    | H    | L  | X   | Write         | Din    | High-Z | Active  |
| L   | H  | L    | H    | H  | L   | Read          | Dout   | High-Z | Active  |
| L   | H  | L    | H    | H  | H   | ——            | High-Z | High-Z | Active  |
| L   | H  | H    | L    | L  | X   | Write         | High-Z | Din    | Active  |
| L   | H  | H    | L    | H  | L   | Read          | High-Z | Dout   | Active  |
| L   | H  | H    | L    | H  | H   | ——            | High-Z | High-Z | Active  |
| L   | H  | L    | L    | L  | X   | Write         | Din    | Din    | Active  |
| L   | H  | L    | L    | H  | L   | Read          | Dout   | Dout   | Active  |
| L   | H  | L    | L    | H  | H   | ——            | High-Z | High-Z | Active  |

BLOCK DIAGRAM



**M5M5W816WG - 85HI****PRELIMINARY**

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**8388608-BIT (524288-WORD BY 16-BIT) CMOS STATIC RAM****ABSOLUTE MAXIMUM RATINGS**

| Symbol           | Parameter             | Conditions            | Ratings                                   | Units |
|------------------|-----------------------|-----------------------|-------------------------------------------|-------|
| V <sub>CC</sub>  | Supply voltage        | With respect to GND   | -0.3* ~ +4.6                              | V     |
| V <sub>I</sub>   | Input voltage         | With respect to GND   | -0.3* ~ V <sub>CC</sub> + 0.3 (max. 4.6V) |       |
| V <sub>O</sub>   | Output voltage        | With respect to GND   | 0 ~ V <sub>CC</sub>                       |       |
| P <sub>d</sub>   | Power dissipation     | T <sub>a</sub> = 25°C | 700                                       | mW    |
| T <sub>a</sub>   | Operating temperature |                       | - 40 ~ +85                                | °C    |
| T <sub>stg</sub> | Storage temperature   |                       | - 65 ~ +150                               | °C    |

\* -3.0V in case of AC (Pulse width ≤ 30ns)

**DC ELECTRICAL CHARACTERISTICS**(V<sub>CC</sub>=2.7 ~ 3.0V, unless otherwise noted)

| Symbol           | Parameter                                   | Conditions                                                                                                                                                                                                                                                                                          | Limits    |     |                       | Units |    |
|------------------|---------------------------------------------|-----------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------|-----------|-----|-----------------------|-------|----|
|                  |                                             |                                                                                                                                                                                                                                                                                                     | Min       | Typ | Max                   |       |    |
| V <sub>IH</sub>  | High-level input voltage                    |                                                                                                                                                                                                                                                                                                     | 2.2       |     | V <sub>CC</sub> +0.2V | V     |    |
| V <sub>IL</sub>  | Low-level input voltage                     |                                                                                                                                                                                                                                                                                                     | -0.2 *    |     | 0.6                   |       |    |
| V <sub>OH</sub>  | High-level output voltage                   | I <sub>OH</sub> = -0.5mA                                                                                                                                                                                                                                                                            | 2.4       |     |                       |       |    |
| V <sub>OL</sub>  | Low-level output voltage                    | I <sub>OL</sub> =2mA                                                                                                                                                                                                                                                                                |           |     | 0.4                   |       |    |
| I <sub>I</sub>   | Input leakage current                       | V <sub>I</sub> =0 ~ V <sub>CC</sub>                                                                                                                                                                                                                                                                 |           |     | ±1                    | μA    |    |
| I <sub>O</sub>   | Output leakage current                      | BC1# and BC2# =V <sub>IH</sub> or S1# =V <sub>IH</sub> or S2=V <sub>IL</sub> or OE# =V <sub>IH</sub> , V <sub>I/O</sub> =0 ~ V <sub>CC</sub>                                                                                                                                                        |           |     | ±1                    |       |    |
| I <sub>CC1</sub> | Active supply current<br>( AC,MOS level )   | BC1# and BC2#≤ 0.2V, S1#≤ 0.2V, S2≥V <sub>CC</sub> -0.2V<br>other inputs ≤ 0.2V or ≥ V <sub>CC</sub> -0.2V<br>Output - open (duty 100%)                                                                                                                                                             | f = 10MHz | -   | 30                    | 40    | mA |
|                  |                                             |                                                                                                                                                                                                                                                                                                     | f = 1MHz  | -   | 5                     | 10    |    |
| I <sub>CC2</sub> | Active supply current<br>( AC,TTL level )   | BC1# and BC2#=V <sub>IL</sub> , S1#=V <sub>IL</sub> ,S2=V <sub>IH</sub><br>other pins =V <sub>IH</sub> or V <sub>IL</sub><br>Output - open (duty 100%)                                                                                                                                              | f = 10MHz | -   | 30                    | 40    |    |
|                  |                                             |                                                                                                                                                                                                                                                                                                     | f = 1MHz  | -   | 5                     | 10    |    |
| I <sub>CC3</sub> | Stand by supply current<br>( AC,MOS level ) | (1) S1# ≥ V <sub>CC</sub> - 0.2V,<br>S2 ≥ V <sub>CC</sub> - 0.2V,<br>other inputs = 0 ~ V <sub>CC</sub><br><br>(2) S2 ≤ 0.2V,<br>other inputs = 0 ~ V <sub>CC</sub><br><br>(3) BC1# and BC2#≥V <sub>CC</sub> - 0.2V<br>S1#≤ 0.2V, S2 ≥ V <sub>CC</sub> - 0.2V<br>other inputs = 0 ~ V <sub>CC</sub> | ~ +25°C   | -   | 0.5                   | 2     | μA |
|                  |                                             |                                                                                                                                                                                                                                                                                                     | ~ +40°C   | -   | 1.0                   | 4     |    |
|                  |                                             |                                                                                                                                                                                                                                                                                                     | ~ +70°C   | -   | -                     | 20    |    |
|                  |                                             |                                                                                                                                                                                                                                                                                                     | ~ +85°C   | -   | -                     | 40    |    |
| I <sub>CC4</sub> | Stand by supply current<br>( AC,TTL level ) | BC1# and BC2# =V <sub>IH</sub> or S1# =V <sub>IH</sub> or S2=V <sub>IL</sub><br>Other inputs= 0 ~ V <sub>CC</sub>                                                                                                                                                                                   | -         | -   | 2                     | mA    |    |

Note 1: Direction for current flowing into IC is indicated as positive (no mark)

\* -3.0V in case of AC (Pulse width ≤ 30ns)

Note 2: Typical parameter indicates the value for the center of distribution, and is not 100% tested.

**CAPACITANCE**(V<sub>CC</sub>=2.7 ~ 3.0V, unless otherwise noted)

| Symbol         | Parameter          | Conditions                                           | Limits |     |     | Units |
|----------------|--------------------|------------------------------------------------------|--------|-----|-----|-------|
|                |                    |                                                      | Min    | Typ | Max |       |
| C <sub>I</sub> | Input capacitance  | V <sub>I</sub> =GND, V <sub>I</sub> =25mVrms, f=1MHz |        |     | 10  | pF    |
| C <sub>O</sub> | Output capacitance | V <sub>O</sub> =GND, V <sub>O</sub> =25mVrms, f=1MHz |        |     | 10  |       |

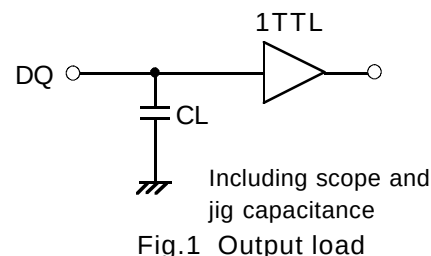


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**8388608-BIT (524288-WORD BY 16-BIT) CMOS STATIC RAM****AC ELECTRICAL CHARACTERISTICS** (V<sub>CC</sub>=2.7 ~ 3.0V, unless otherwise noted)**(1) TEST CONDITIONS**

|                               |                                                                                                                                                    |
|-------------------------------|----------------------------------------------------------------------------------------------------------------------------------------------------|
| Supply voltage                | 2.7~3.0V                                                                                                                                           |
| Input pulse                   | V <sub>IH</sub> =2.4V, V <sub>IL</sub> =0.4V                                                                                                       |
| Input rise time and fall time | 5ns                                                                                                                                                |
| Reference level               | V <sub>OH</sub> =V <sub>OL</sub> =1.5V <small>Transition is measured ±200mV from steady state voltage.(for t<sub>en</sub>,t<sub>dis</sub>)</small> |
| Output loads                  | Fig.1,CL=30pF<br>CL=5pF (for t <sub>en</sub> ,t <sub>dis</sub> )                                                                                   |

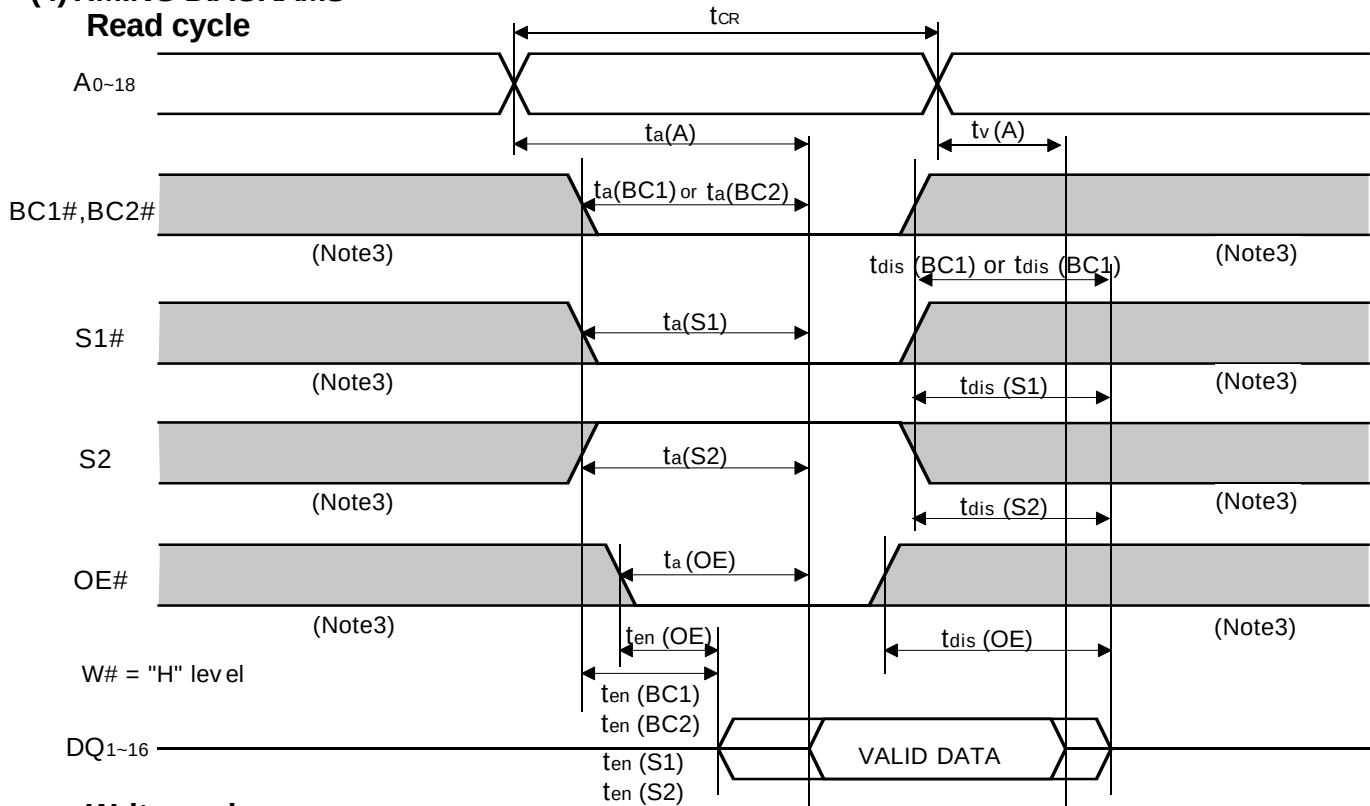
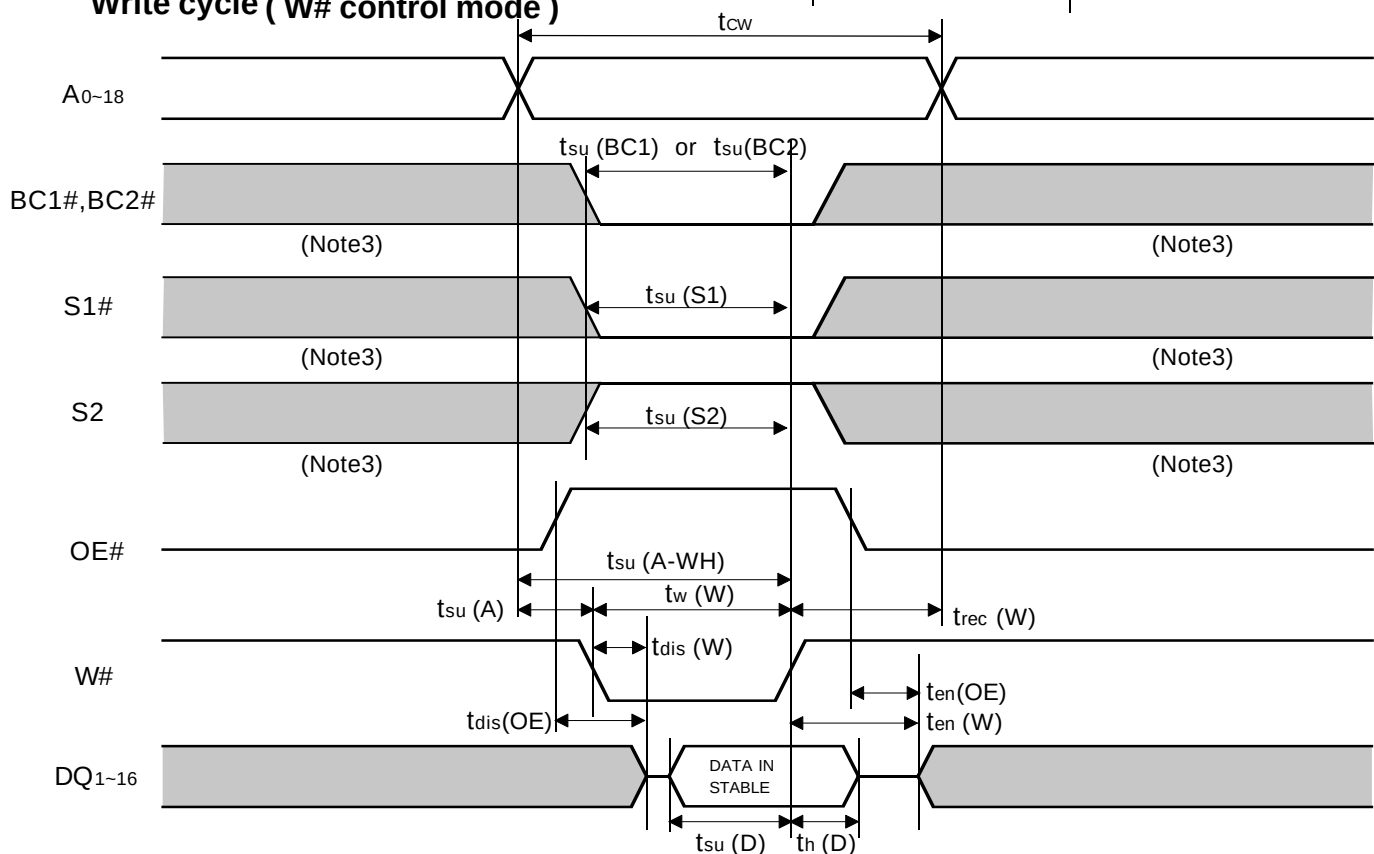
**(2) READ CYCLE**

| Symbol                 | Parameter                           | Limits |     | Units |
|------------------------|-------------------------------------|--------|-----|-------|
|                        |                                     | Min    | Max |       |
| t <sub>CR</sub>        | Read cycle time                     | 85     |     | ns    |
| t <sub>a</sub> (A)     | Address access time                 |        | 85  | ns    |
| t <sub>a</sub> (S1)    | Chip select 1 access time           |        | 85  | ns    |
| t <sub>a</sub> (S2)    | Chip select 2 access time           |        | 85  | ns    |
| t <sub>a</sub> (BC1)   | Byte control 1 access time          |        | 85  | ns    |
| t <sub>a</sub> (BC2)   | Byte control 2 access time          |        | 85  | ns    |
| t <sub>a</sub> (OE)    | Output enable access time           |        | 45  | ns    |
| t <sub>dis</sub> (S1)  | Output disable time after S1# high  |        | 30  | ns    |
| t <sub>dis</sub> (S2)  | Output disable time after S2 low    |        | 30  | ns    |
| t <sub>dis</sub> (BC1) | Output disable time after BC1# high |        | 30  | ns    |
| t <sub>dis</sub> (BC2) | Output disable time after BC2# high |        | 30  | ns    |
| t <sub>dis</sub> (OE)  | Output disable time after OE# high  |        | 30  | ns    |
| t <sub>en</sub> (S1)   | Output enable time after S1# low    | 10     |     | ns    |
| t <sub>en</sub> (S2)   | Output enable time after S2 high    | 10     |     | ns    |
| t <sub>dis</sub> (BC1) | Output enable time after BC1# low   | 5      |     | ns    |
| t <sub>dis</sub> (BC2) | Output enable time after BC2# low   | 5      |     | ns    |
| t <sub>en</sub> (OE)   | Output enable time after OE# low    | 5      |     | ns    |
| t <sub>v</sub> (A)     | Data valid time after address       | 10     |     | ns    |

**(3) WRITE CYCLE**

| Symbol                 | Parameter                             | Limits |     | Units |
|------------------------|---------------------------------------|--------|-----|-------|
|                        |                                       | Min    | Max |       |
| t <sub>cw</sub>        | Write cycle time                      | 85     |     | ns    |
| t <sub>w</sub> (W)     | Write pulse width                     | 60     |     | ns    |
| t <sub>su</sub> (A)    | Address setup time                    | 0      |     | ns    |
| t <sub>su</sub> (A-WH) | Address setup time with respect to W# | 70     |     | ns    |
| t <sub>su</sub> (BC1)  | Byte control 1 setup time             | 70     |     | ns    |
| t <sub>su</sub> (BC2)  | Byte control 2 setup time             | 70     |     | ns    |
| t <sub>su</sub> (S1)   | Chip select 1 setup time              | 70     |     | ns    |
| t <sub>su</sub> (S2)   | Chip select 2 setup time              | 70     |     | ns    |
| t <sub>su</sub> (D)    | Data setup time                       | 45     |     | ns    |
| t <sub>h</sub> (D)     | Data hold time                        | 0      |     | ns    |
| t <sub>rec</sub> (W)   | Write recovery time                   | 0      |     | ns    |
| t <sub>dis</sub> (W)   | Output disable time from W# low       |        | 30  | ns    |
| t <sub>dis</sub> (OE)  | Output disable time from OE# high     |        | 30  | ns    |
| t <sub>en</sub> (W)    | Output enable time from W# high       | 5      |     | ns    |
| t <sub>en</sub> (OE)   | Output enable time from OE# low       | 5      |     | ns    |



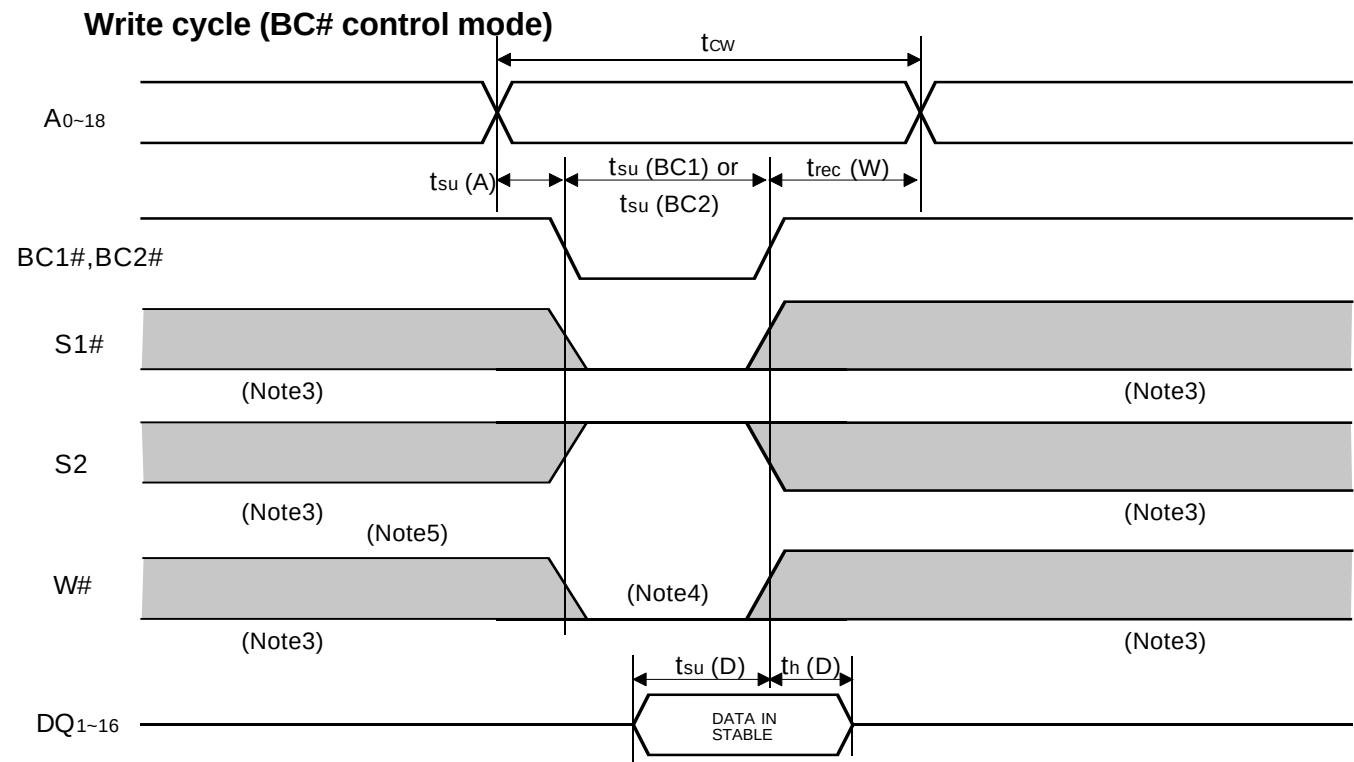
**M5M5W816WG - 85HI****PRELIMINARY**Notice: This is not a final specification.  
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8388608-BIT (524288-WORD BY 16-BIT) CMOS STATIC RAM



- Note 3: Hatching indicates the state is "don't care".
- Note 4: A Write occurs during S1# low, S2 high overlaps BC1# and/or BC2# low and W# low.
- Note 5: When the falling edge of W# is simultaneously or prior to the falling edge of BC1# and/or BC2# or the falling edge of S1# or rising edge of S2, the outputs are maintained in the high impedance state.
- Note 6: Don't apply inverted phase signal externally when DQ pin is in output mode.

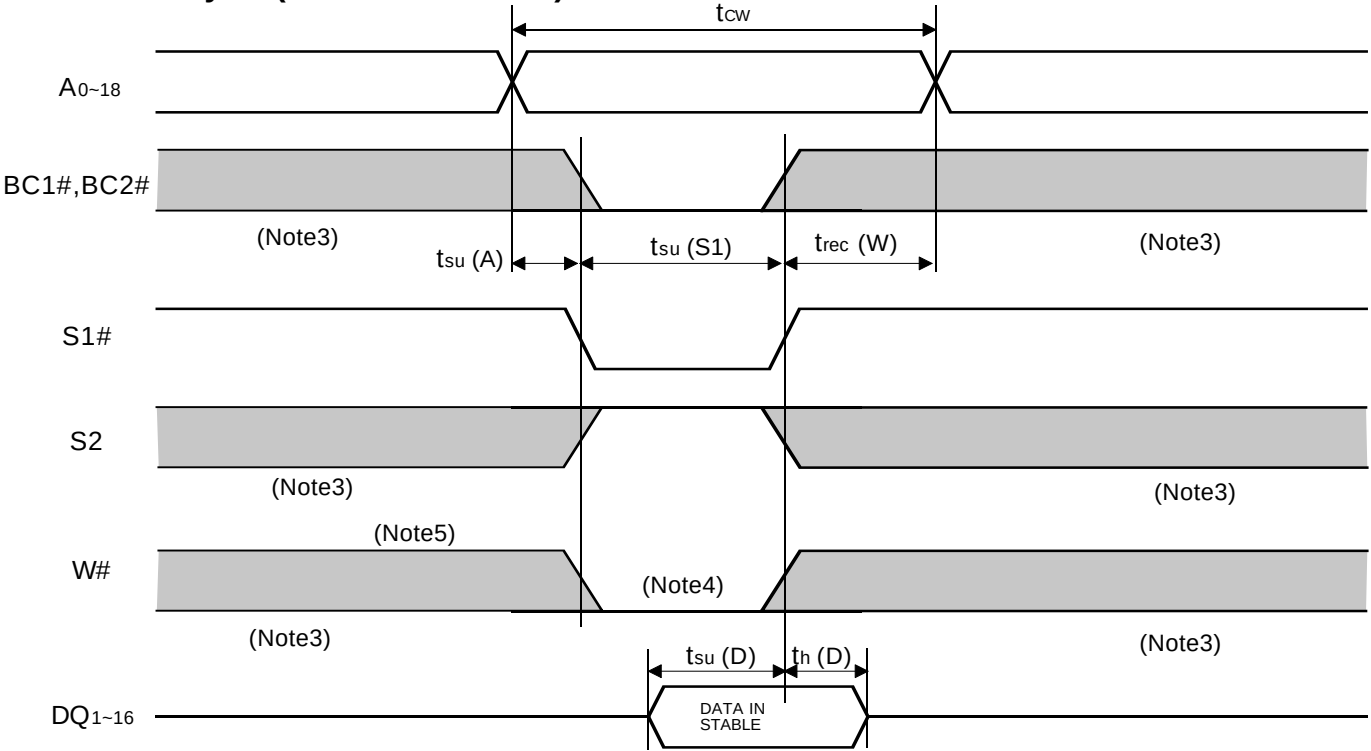
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**PRELIMINARY**

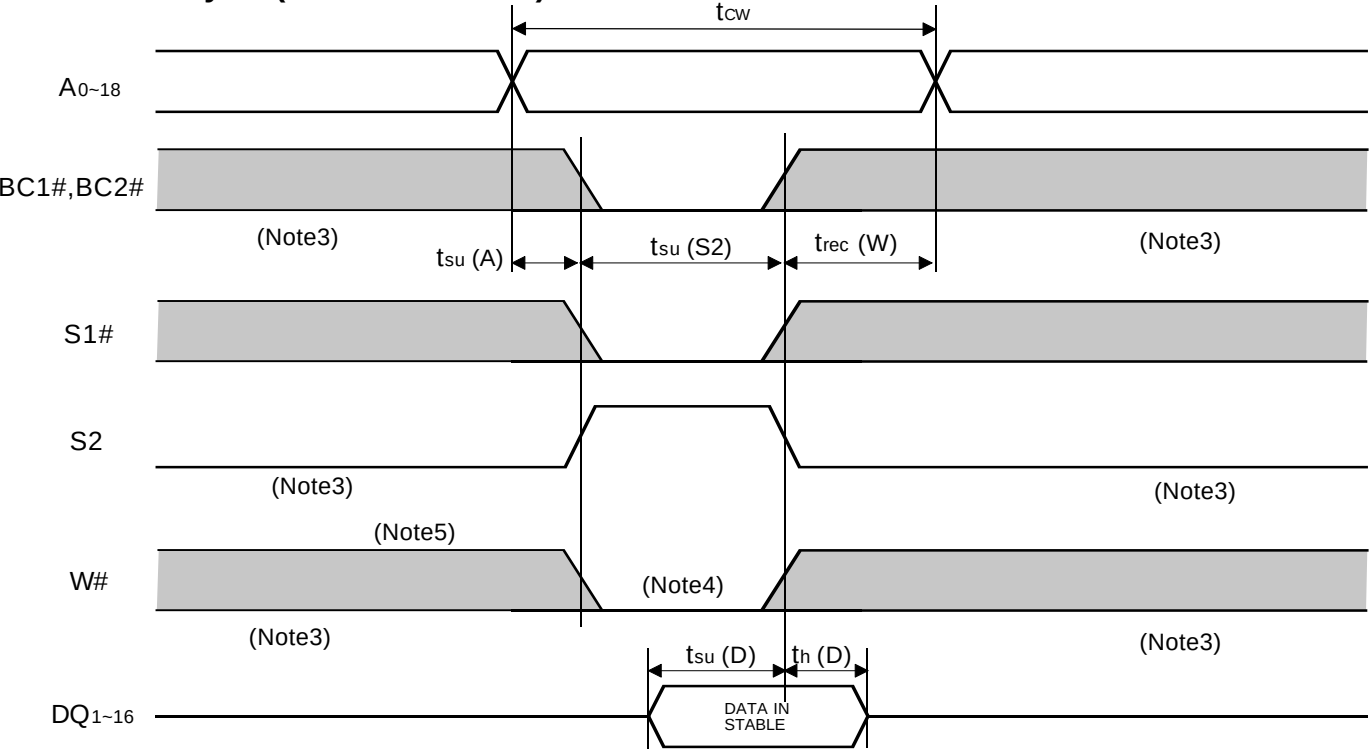
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8388608-BIT (524288-WORD BY 16-BIT) CMOS STATIC RAM

## Write cycle (S1# control mode)



## Write cycle (S2 control mode)



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**8388608-BIT (524288-WORD BY 16-BIT) CMOS STATIC RAM****POWER DOWN CHARACTERISTICS****(1) ELECTRICAL CHARACTERISTICS**

| Symbol               | Parameter                      | Test conditions                                                                                                                                                                                                                                                                         |         | Limits |                      |     | Units |
|----------------------|--------------------------------|-----------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------|---------|--------|----------------------|-----|-------|
|                      |                                |                                                                                                                                                                                                                                                                                         |         | Min    | Typ                  | Max |       |
| V <sub>CC</sub> (PD) | Power down supply voltage      |                                                                                                                                                                                                                                                                                         |         | 2.0    |                      |     | V     |
| V <sub>I</sub> (BC#) | Byte control input BC1# & BC2# | 2.2V <sub>≤</sub> V <sub>CC</sub> (PD)                                                                                                                                                                                                                                                  |         | 2.0    |                      |     | V     |
|                      |                                | 2.0V <sub>≤</sub> V <sub>CC</sub> (PD) <sub>≤</sub> 2.2V                                                                                                                                                                                                                                |         |        | V <sub>CC</sub> (PD) |     |       |
| V <sub>I</sub> (S1#) | Chip select input S1#          | 2.2V <sub>≤</sub> V <sub>CC</sub> (PD)                                                                                                                                                                                                                                                  |         | 2.0    |                      |     | V     |
|                      |                                | 2.0V <sub>≤</sub> V <sub>CC</sub> (PD) <sub>≤</sub> 2.2V                                                                                                                                                                                                                                |         |        | V <sub>CC</sub> (PD) |     |       |
| V <sub>I</sub> (S2)  | Chip select input S2           |                                                                                                                                                                                                                                                                                         |         |        |                      | 0.2 |       |
| I <sub>CC</sub> (PD) | Power down supply current      | V <sub>CC</sub> =2.0V<br>(1) S1# ≥ V <sub>CC</sub> - 0.2V,<br>other inputs = 0 ~ V <sub>CC</sub><br>(2) S2 ≤ 0.2V,<br>other inputs = 0 ~ V <sub>CC</sub><br>(3) BC1# and BC2# ≥ V <sub>CC</sub> - 0.2V<br>S1# ≤ 0.2V, S2 ≥ V <sub>CC</sub> - 0.2V<br>other inputs = 0 ~ V <sub>CC</sub> | ~ +25°C | -      | 0.1                  | 1.5 | μA    |
|                      |                                |                                                                                                                                                                                                                                                                                         | ~ +40°C | -      | 0.2                  | 3   |       |
|                      |                                |                                                                                                                                                                                                                                                                                         | ~ +70°C | -      | -                    | 15  |       |
|                      |                                |                                                                                                                                                                                                                                                                                         | ~ +85°C | -      | -                    | 30  |       |

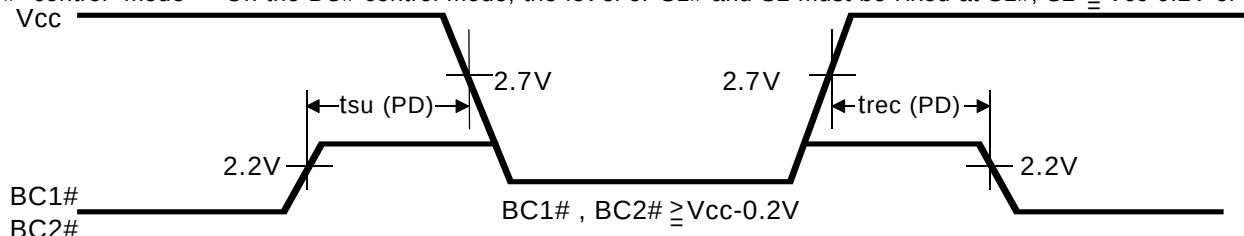
Note 2: Typical parameter of I<sub>CC</sub>(PD) indicates the value for the center of distribution, and is not 100% tested.

**(2) TIMING REQUIREMENTS**

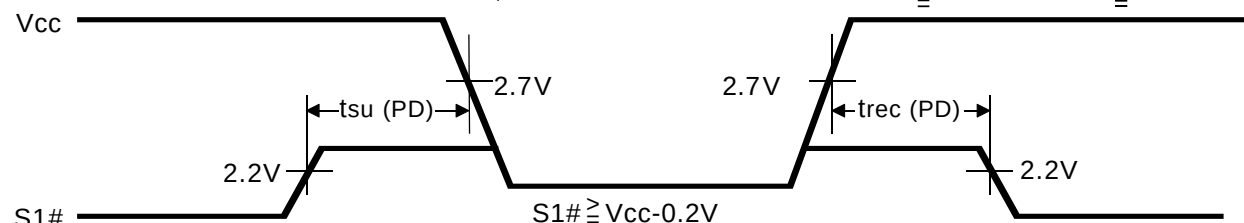
| Symbol                | Parameter                | Test conditions | Limits |     |     | Units |
|-----------------------|--------------------------|-----------------|--------|-----|-----|-------|
|                       |                          |                 | Min    | Typ | Max |       |
| t <sub>su</sub> (PD)  | Power down set up time   |                 | 0      |     |     | ns    |
| t <sub>rec</sub> (PD) | Power down recovery time |                 | 5      |     |     | ms    |

**(3) TIMING DIAGRAM**

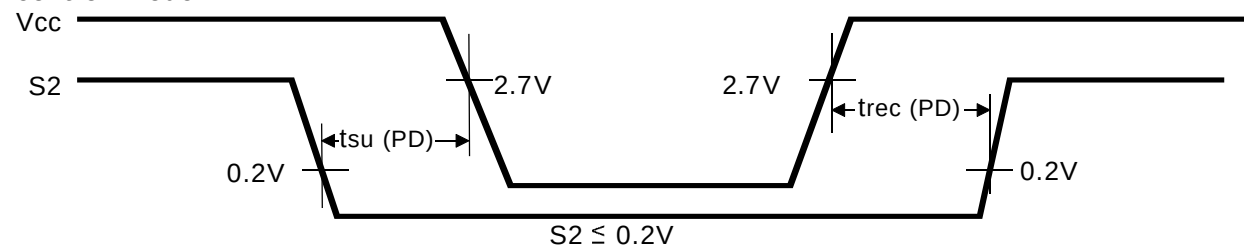
BC# control mode On the BC# control mode, the level of S1# and S2 must be fixed at S1#, S2  $\geq V_{CC} - 0.2V$  or S2  $\leq 0.2V$



S1# control mode On the S1# control mode, the level of S2 must be fixed at S2  $\geq V_{CC} - 0.2V$  or S2  $\leq 0.2V$

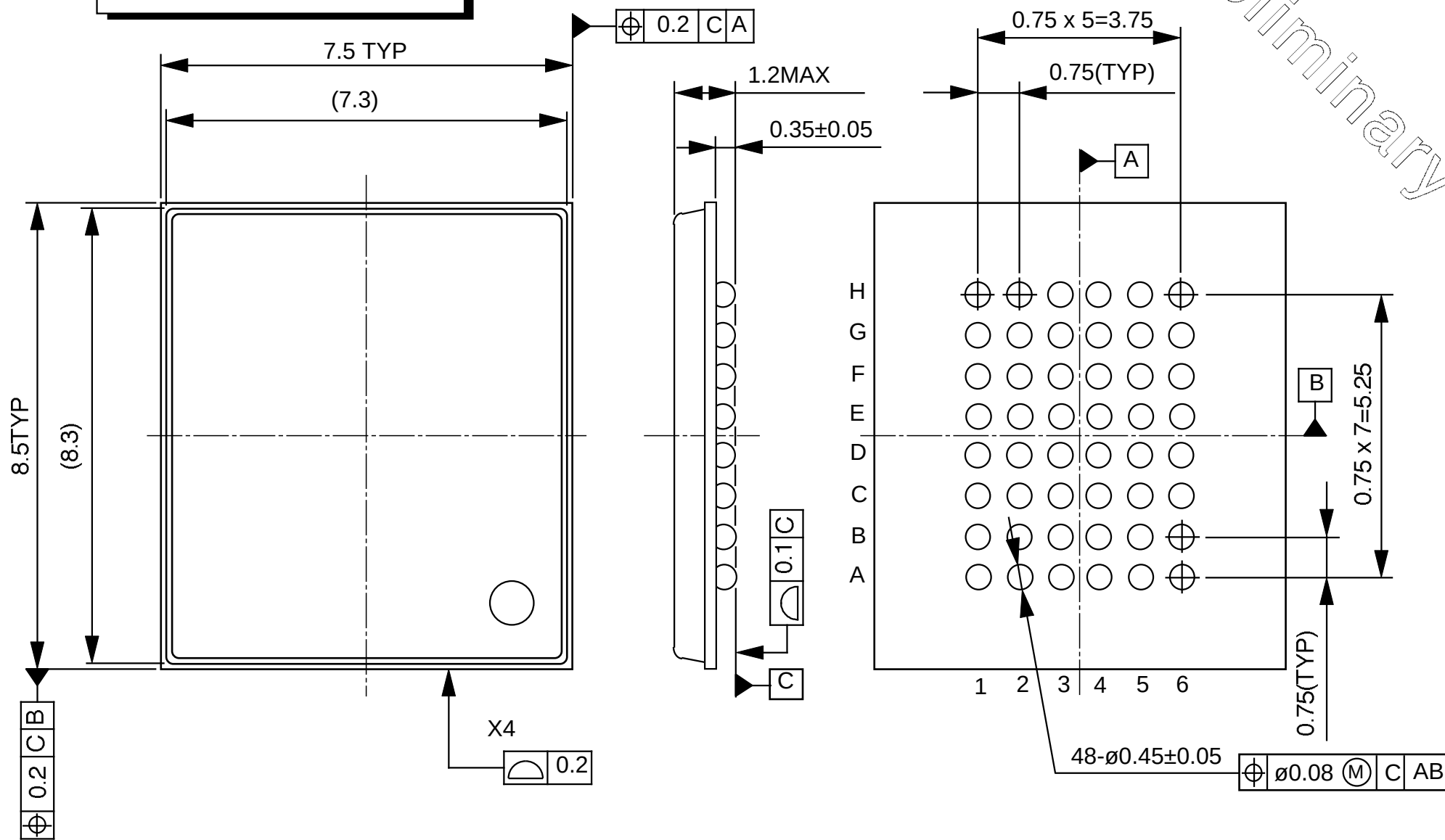


S2 control mode





**48FBGA for 8MSRAM**



preliminary

## **Keep safety first in your circuit designs!**

Mitsubishi Electric Corporation puts the maximum effort into making semiconductor products better and more reliable, but there is always the possibility that trouble may occur with them. Trouble with semiconductors may lead to personal injury, fire or property damage. Remember to give due consideration to safety when making your circuit designs, with appropriate measures such as (i) placement of substitutive, auxiliary circuits, (ii) use of non-flammable material or (iii) prevention against any malfunction or mishap.

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